Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/811,074 Examiner	PAN, FENG
Jeffrey S. Zweizig	2816

CEARCHER					
	SEARCHED				
Class	Subclass	Date	Examiner		
327	530	4/13/2005	JZ		
	534				
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update	above	11/1/05	JZ		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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	Subclass	Subclass Date		

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
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